

Notice of References Cited

Application/Control No.

09/986,632

Applicant(s)/Patent Under
Reexamination
AGUERA ET AL.

Examiner

Ramin (Ray) Akhavan

Art Unit

1636

Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-2003/0125274 A1	07-2003	Gaarde et al.	514/44
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Anderson, F.W. Nature, 392 (Supp):25-30 (1998)
	V	Check, E. Nature, 421:678 (2003)
	W	Cohen et al. J. Neurochem., 85:1262-78 (2003).
	X	Juengst, E.T. BMJ, 326:1410-1411 (2003)

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

09/986,632

Applicant(s)/Patent Under
Reexamination
AGUERA ET AL.

Examiner

Ramin (Ray) Akhavan

Art Unit

1636

Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Ricard et al. J. Neurosci. 21(18):7203-14 (2001).
	V	Wang and Strittmatter. J. Neurosci. 16(19):6197-207 (1996).
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.